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- Inputs Are TTL Compatible
- **EPIC™** (Enhanced-Performance Implanted CMOS) 1-µm Process
- **Package Options Include Plastic** Small-Outline (DW), Shrink Small-Outline (DB), Thin Shrink Small-Outline (PW), and DIP (N) Packages, Ceramic Chip Carriers (FK), Flat (W), and DIP (J) Packages

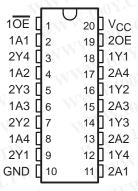
description

These octal buffers and line drivers are designed specifically to improve the performance and density of 3-state memory address drivers, clock drivers. and bus-oriented receivers transmitters.

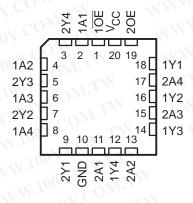
The 'ACT241 are organized as two 4-bit buffers/drivers with separate complementary output-enable (10E and 20E) inputs. When 10E is low or 20E is high, the device passes noninverted data from the A inputs to the Y outputs. When $1\overline{OE}$ is high or 2OE is low, the outputs are in the high-impedance state.

The SN54ACT241 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ACT241 is characterized for operation from -40°C to 85°C.

SN54ACT241 . . . J OR W PACKAGE SN74ACT241 . . . DB, DW, N, OR PW PACKAGE (TOP VIEW)



SN54ACT241 . . . FK PACKAGE (TOP VIEW)



FUNCTION TABLES

ч			-
٥	INPL	JTS	OUTPUT
1	10E	1A	1Y
	V.Co	H	Н
	LC() L	L
	Н	X	Z

U ~						
INP	JTS	OUTPUT				
20E	2A	2Y				
H	H	Н				
H	L	TIM				
L	X	Z				

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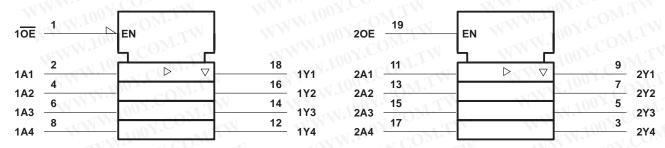


SN54ACT241, SN74ACT241 OCTAL BUFFERS/DRIVERS WITH 3-STATE OUTPUTS

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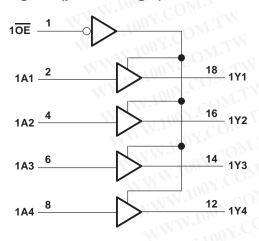
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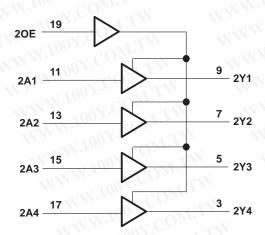
logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V _I (see Note 1)	0.5 V to V _{CC} + 0.5 V
Output voltage range, V _O (see Note 1)	\dots -0.5 V to V _{CC} + 0.5 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC})	±20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±50 mA
Continuous current through V _{CC} or GND	±200 mA
Maximum power dissipation at $T_A = 55^{\circ}$ C (in still air) (see Note 2	2): DB package 0.6 W
	D package 1.6 W
	N package 1.3 W
	PW package 0.7 W
Storage temperature range, T _{stq}	–65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.



^{2.} The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils, except for the N package, which has a trace length of zero.

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recommended operating conditions (see Note 3)

MM	TION WITH WITH THE	SN54A	CT241	SN74A		
	W. TO COM TW WWW. ON COM TW	MIN	MAX	MIN	MAX	UNIT
Vcc	Supply voltage	4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2	MM^{-1}	2	CO_{M_I}	V
V _{IL}	Low-level input voltage	AA	0.8	700 r.	0.8	V
V _I	Input voltage	0	Vcc	0	VCC	V
VO	Output voltage	0	VCC	0	VCC	V
loh	High-level output current		-24	W.In.	-24	mA
loL	Low-level output current		24	JV.10	24	mA
Δt/Δν	Input transition rise or fall rate	0	8	0	00.8	ns/V
TA	Operating free-air temperature	√ – 55	125	-40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS	.,	T _A = 25°C			SN54ACT241		SN74ACT241		00
PARAMETER		VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
	I _{OH} = -50 μA	4.5 V	4.4	4.49	Y.Co	4.4	N	4.4	MA.	1003
		5.5 V	5.4	5.49	N.C	5.4		5.4	NW	
	I _{OL} = -24 mA	4.5 V	3.86	W.M	-1 (3.7	-31	3.76		N_{IO}
VOH		5.5 V	4.86	-33 1	001.	4.7	1.11	4.76	AA.	V
	$I_{OH} = -50 \text{ mA}^{\dagger}$	5.5 V	W	M.	1007	3.85	TW		4//	
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V	<	WWW		1.COz		3.85	M	
	1- 50 W STW-100 COM.	4.5 V		0.001	0.1	-1 CO	0.1	- XI	0.1	WW.
	Ι _Ο L = 50 μΑ	5.5 V		0.001	0.1	27.	0.1	7	0.1	
V	I _{OL} = 24 mA	4.5 V		MM	0.36	101.C	0.5	IN	0.44	
VOL		5.5 V		11/	0.36	oov.	0.5	W	0.44	
	I _{OL} = 50 mA [†]	5.5 V	« 1		WW	100	1.65	LOP		
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V	M			1700 2		$M_{i,I,A}$	1.65	
loz	$V_O = V_{CC}$ or GND	5.5 V		1	±0.25	-1100	±5	TIM	±2.5	μΑ
l _l	V _I = V _{CC} or GND	5.5 V	TW		±0.1	14.	±1) · ·	√√ ±1	μΑ
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V	. 1		4	111.70	80	OMr.	40	μA
Δl _{CC} ‡	One input at 3.4 V, Other inputs at GND or V _{CC}	5.5 V	T.I.	0.6	W	WW.1	1.6	CO_{M}	1.5	m
Ci	V _I = V _{CC} or GND	5 V	Mr.	2.5		WW		1.COD	TV	pF
Co	V _I = V _{CC} or GND	5 V	Mi	8			1.100	CO	Mr.	pF

T Not more than one output should be tested at a time, and the duration of the test should not exceed 2 ms.



[‡]This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

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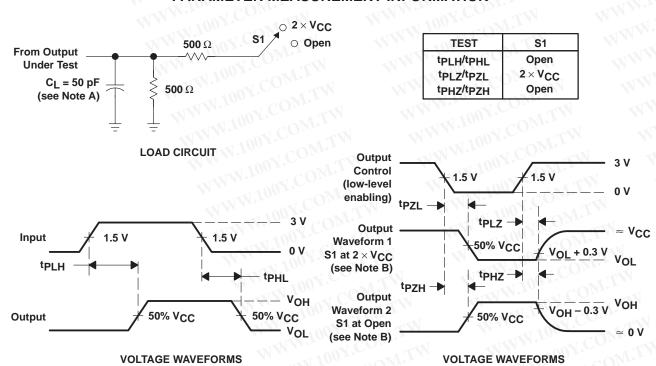
switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

DADAMETER	FROM	TO (OUTPUT)	CT,	T _A = 25°C		SN54ACT241		SN74ACT241		UNIT
PARAMETER	(INPUT)		MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNH
^t PLH	DOY. AM.TW	Y 1 1 1 1	1.5	6	8.5	1	9.5	1.5	9.5	ns
tPHL	ON CAME		1.5	5.5	7.5	1	9	1.5	8.5	
^t PZH	ON TO	N YWWW	1.5	C 7	8.5	1	10	1	9.5	DO P
^t PZL	OE or OE		I V	2	J (7)	9.5	1	11.5	1.5	10.5
^t PHZ	OF or OF	Y	1 2	8	9.5	1	11	2	10.5	- cO
t _{PLZ}	OE or OE		TOW Y WW	2.5	6.5	10	1	11.5	2	10.5

operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER		TWW.IOO	TYP	UNIT		
C _{pd}	Power dissipation capacitance per buffer/driver	M. 1001.	$C_L = 50 \text{ pF},$	f = 1 MHz	45	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: $PRR \le 1$ MHz, $Z_O = 50 \Omega$, $t_f \le 2.5$ ns, $t_f \le 2.5$ ns.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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